



SJMOS N-MOSFET 650V, $42m\Omega$, 74A

Features

- CRM(CQ) Super_Junction technology
- Much lower Ron*A performance for On-state efficiency
- Better efficiency due to very low FOM
- Ultra-fast body diode
- Qualified for industrial grade applications according to JEDEC

Applications

- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

Product Summary

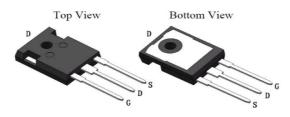
VDS	650V
$R_{DS(on)_typ}$	42mΩ
I_{D}	74A

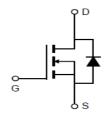
100% DVDS Tested

100% Avalanche Tested









Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJQ41N65GCF	CRJQ41N65GCF	TO-247-3L	Tube	N/A	N/A	25/30pcs

Absolute Maximum Ratings(at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	650	V
Continuous drain current 1)			
$T_C = 25$ °C	I_D	74	Α
$T_C = 100$ °C		47	
Pulsed drain current $^{2)}$ (T _C = 25°C, t _p limited by T _{jmax})	I _{D pulse}	296	Α
Avalanche energy, single pulse (L=30mH)	E _{AS}	1500	mJ
MOSFET dv/dt ruggedness	dv/dt	50	V/ns
Gate-Source voltage	V_{GS}	±30	V
Power dissipation ($T_C = 25^{\circ}C$)	P _{tot}	687	W
Continuous diode forward current($T_C = 25$ °C)	Is	74	А
Diode pulse current ²⁾ (T _C = 25°C)	I _{S pulse}	296	А
Recovery diode dv/dt 3)	dv/dt	50	V/ns
Maximum diode commutation speed	di _F /dt	900	A/µs
Operating junction and storage temperature	T_j , T_{stg}	-55+150	°C

¹⁾ Limited by Tj,max. Maximum Duty Cycle D = 0.50; TO-220 equivalent 2) Pulse width tp limited by Tj,max

³⁾ Identical low side and high side switch with identical RG



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Thermal Resistance

Parameter	Symbol	Value			Unit	Test Condition
raiailletei	Syllibol	min.	typ.	max.	Oilit	rest condition
Thermal resistance, junction – case	R_{thJC}	-	0.13	0.18	°C/W	
Thermal resistance, junction – ambient	R _{thJA}	-	-	45	°C/W	

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Danamatan	Cumbal	Value			11	Took Condition	
Parameter	Symbol	min.	typ.	max.	Unit	Test Condition	
Static Characteristic							
Drain-source breakdown voltage	BV _{DSS}	650	-	-	V	V _{GS} =0V, I _D =250uA	
Gate threshold voltage	V _{GS(th)}	3.3	-	4.6	V	V _{DS} =V _{GS} ,I _D =250uA	
						V _{DS} =650V,V _{GS} =0V	
Zero gate voltage drain current	I_{DSS}	-	-	5	μΑ	T _j =25°C	
		-	1000	-		T _j =150°C	
Gate-source leakage current	I_{GSS}	-	-	±100	nA	$V_{GS}=\pm30V, V_{DS}=0V$	
						V _{GS} =10V, I _D =35A,	
Drain-source on-state resistance	R _{DS(on)}	-	42	48	mΩ	T _j =25°C	
		-	110	-		T _j =150°C	
Transconductance	g _{fs}	-	39	_	S	V _{DS} =20V,I _D =35A	
Dynamic Characteristic							
Input Capacitance	C _{iss}	-	6594	_			
Output Capacitance	C _{oss}	-	245	-	pF	V_{GS} =0V, V_{DS} =100V, f =1MHz	
Reverse Transfer Capacitance	C _{rss}	-	2.4	-			
Gate Total Charge	Q_{G}	-	168	-			
Gate-Source charge	Q_{gs}	ı	57	-	nC	V _{GS} =10V, V _{DS} =480V,	
Gate-Drain charge	Q_{gd}	ı	88	-		I _D =35A	
Gate plateau voltage	$V_{plateau}$	-	8.2	-	V		
Turn-on delay time	t _{d(on)}	-	179	-			
Rise time	t _r	-	115	-		V _{GS} =10V, I _D =35A,	
Turn-off delay time	t _{d(off)}	-	312	-	ns	V_{DS} =400V, R_g =27 Ω	
Fall time	t _f	-	104	-			
Gate resistance	R_{gint}	-	1.0	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz	





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Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition	
Parameter	Symbol	min.	typ.	max.	Unit	rest Condition	
Body Diode Forward Voltage	V_{SD}	0.7	0.91	1.2	V	$V_{GS}=0V,I_{SD}=35A$	
Body Diode Reverse Recovery Time	t _{rr}	-	194	-	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	-	1.54	-	uC	Isd=35A dI/dt=100A/us,Vds=400V	
Body Diode Reverse Recovery Peak Current	I _{rrm}	-	14.8	-	А		



Typical Performance Characteristics

Fig 1. Output Characteristics (Tj=25°C)

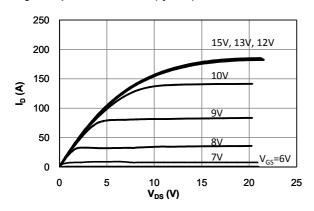


Fig 2. Output Characteristics (Tj=150℃)

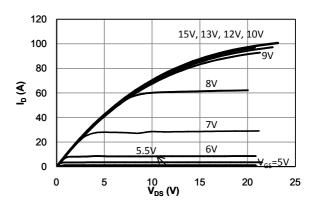


Fig 3: Transfer Characteristics

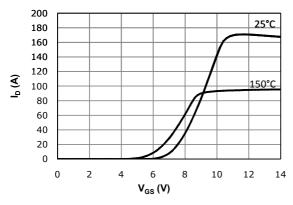


Fig 4: V_{TH} Vs Tj Temperature Characteristics

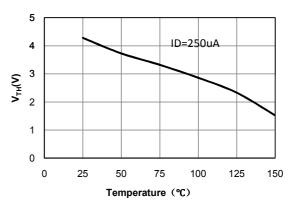


Fig 5: Rdson Vs Ids Characteristics(Tj=25°C)

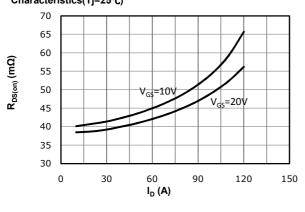


Fig 6: Rds(on) vs. Temperature

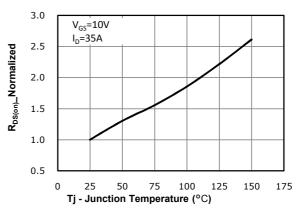




Fig 7: BVDSS vs. Temperature

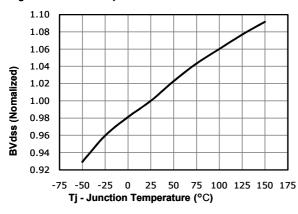


Fig 8: Rds(on) vs Gate Voltage

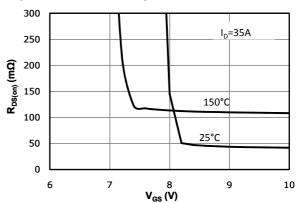


Fig 9: Body-diode Forward Characteristics

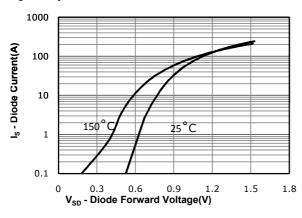


Fig 10: Gate Charge Characteristics

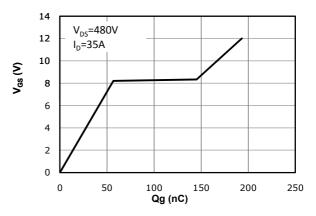


Fig 11: Capacitance Characteristics

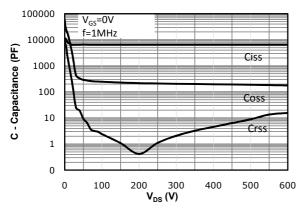
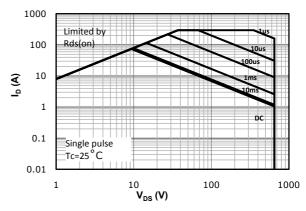
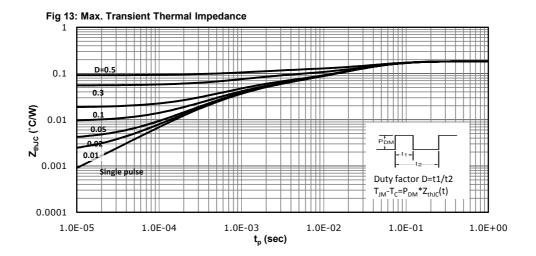


Fig 12: Safe Operating Area



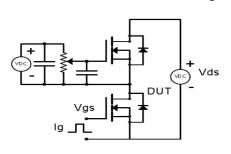


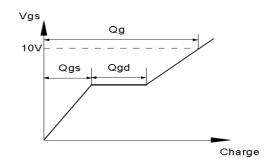




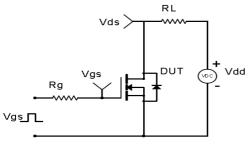
Test Circuit & Waveform

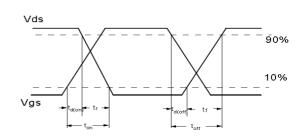
Gate Charge Test Circuit & Waveform



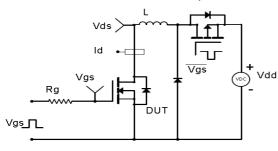


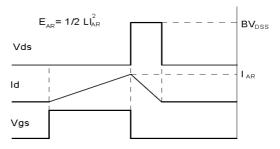
Resistive Switching Test Circuit & Waveforms



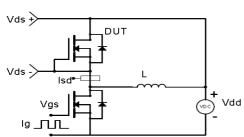


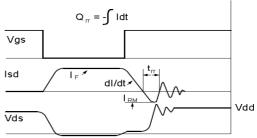
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





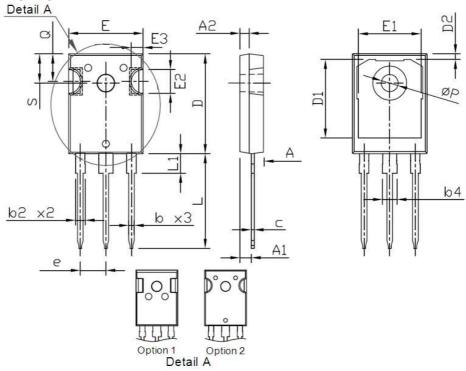
Diode Recovery Test Circuit & Waveforms







Package Outline: TO-247



Symbol	Dimensions In I	Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.70	5.30	0.185	0.209
A1	2.20	2.60	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	1.04	1.33	0.041	0.052
b2	1.90	2.41	0.075	0.095
b4	2.87	3.43	0.113	0.135
С	0.55	0.70	0.022	0.028
D	20.70	21.30	0.815	0.839
D1	16.25	17.65	0.640	0.695
D2	0.51	1.40	0.020	0.055
е	5.44 BS	ic.	0.21	4 BSC.
E	15.50	16.30	0.610	0.642
E1	13.08	14.16	0.515	0.557
E2	3.80	5.49	0.150	0.216
E3	1.00	2.75	0.039	0.108
L	19.72	20.32	0.776	0.800
L1	3.85	4.50	0.152	0.177
Q	5.25	6.25	0.207	0.246
Р	3.50	3.70	0.138	0.146
S	6.04	6.30	0.238	0.248



Marking



NOTE:

NXBBAAAAY

X —Assembly location code

BB —Fab code AAAA —Lot code Y —Bin code

Revision History

ICCVISION THIS	/1 y	
Revison	Date	Major changes
4.0	2022-08-25	Update Datasheet Template

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.